


<b>Search Notes</b>  	<b>Application/Control No.</b>  10504817	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAKUWA ET AL.
	<b>Examiner</b>  SYED Y HASAN	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	125	3/10/2008	Syed Y. Hasan
386	46	3/10/2008	Syed Y. Hasan
386	52	3/10/2008	Syed Y. Hasan
386	95	3/10/2008	Syed Y. Hasan
386	98	3/10/2008	Syed Y. Hasan
386	111	3/10/2008	Syed Y. Hasan
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348	423.1	3/10/2008	Syed Y. Hasan
348	432.1	3/10/2008	Syed Y. Hasan
348	584	3/10/2008	Syed Y. Hasan
369	30.03	3/10/2008	Syed Y. Hasan
369	47.2	3/10/2008	Syed Y. Hasan
369	59.25	3/10/2008	Syed Y. Hasan

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB	3/6/2008	SYH
Consultation with Thai Tran	3/6/2008	SYH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner